U.S. PATENT DOCUMENTS

EXAMINER	DOCUME	ENT				FILING DATE
INITIAL	NUMBE	R DATE	NAME	CLASS	SUBCLASS	If Appropriate

FOREIGN PATENT DOCUMENTS

						TRANSLATION	
EXAMINER	DOCUMENT						
INITIAL	NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	YES	NO
BN	61-166774	10/16/86	Japan	B25C	5/02		Х
	62-46324	10/01/87	Japan	B27F	7/17		X
1	7-505339	06/15/95	Japan	B25C	5/02		X
BN	DE 10246176 A1	04/17/03	Germany	H02P	5/41		X

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

DATE CONSIDERED

EXAMINER	12 N	DATE CONSIDERED	3-12-06
*EXAMINER:	Initial citation considered, whether or not citation is	n conformance with MP	EP 609: Draw line

* These references considered only to the extent of their drawings.

1

EXAMINER

through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.